

| Unit Loading/Fan Out |  |  |  |
| :---: | :---: | :---: | :---: |
| Pin Names | Description | U.L. HIGH/LOW | Input $I_{\text {IH }} / I_{\text {IL }}$ <br> Output $\mathrm{I}_{\mathrm{OH}} \mathrm{I}_{\mathrm{OL}}$ |
| $\mathrm{A}_{0}-\mathrm{A}_{3}$ | Address Inputs | 1.0/1.0 | $20 \mu \mathrm{~A} /-0.6 \mathrm{~mA}$ |
| $\bar{E}_{1}$ | Enable Input (Active Low) | 1.0/1.0 | $20 \mu \mathrm{~A} /-0.6 \mathrm{~mA}$ |
| $\mathrm{E}_{2}$ | Enable Input (Active HIGH) | 1.0/1.0 | $20 \mu \mathrm{~A} /-0.6 \mathrm{~mA}$ |
| $\overline{\mathrm{OE}}$ | Output Enable Input (Active LOW) | 1.0/1.0 | $20 \mu \mathrm{~A} /-0.6 \mathrm{~mA}$ |
| P | Polarity Control Input | 1.0/1.0 | $20 \mu \mathrm{~A} /-0.6 \mathrm{~mA}$ |
| $\mathrm{O}_{0}-\mathrm{O}_{9}$ | 3-STATE Outputs | 150/40 (33.3) | $-3 \mathrm{~mA} / 24 \mathrm{~mA}(20 \mathrm{~mA})$ |

Truth Table



| Absolute Maximum Ratings (Note 1) |  |
| :--- | ---: |
| Storage Temperature | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Ambient Temperature under Bias | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| Junction Temperature under Bias | $-55^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| V $_{\mathrm{cc}}$ Pin Potential to Ground Pin | -0.5 V to +7.0 V |
| Input Voltage (Note 2) | -0.5 V to +7.0 V |
| Input Current (Note 2) | -30 mA to +5.0 mA | Voltage Applied to Output


| in HIGH State (with $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ ) |  |
| :--- | ---: |
| Standard Output | -0.5 V to $\mathrm{V}_{\mathrm{CC}}$ |
| 3-STATE Output | -0.5 V to +5.5 V |

## Recommended Operating Conditions

| Free Air Ambient Temperature | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ |
| :--- | ---: |
| Supply Voltage | +4.5 V to +5.5 V |

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied
Note 2: Either voltage limit or current limit is sufficient to protect inputs.
Current Applied to Output
in LOW State (Max)
twice the rated $\mathrm{I}_{\mathrm{OL}}(\mathrm{mA})$

## DC Electrical Characteristics

| Symbol | Parameter | Min | Typ | Max | Units | $\mathrm{V}_{\mathrm{cc}}$ | Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{H}}$ | Input HIGH Voltage | 2.0 |  |  | V |  | Recognized as a HIGH Signal |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage |  |  | 0.8 | V |  | Recognized as a LOW Signal |
| $\mathrm{V}_{C D}$ | Input Clamp Diode Voltage |  |  | -1.2 | V | Min | $\mathrm{I}_{\mathrm{N}}=-18 \mathrm{~mA}$ |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH $10 \% \mathrm{~V}_{\mathrm{CC}}$ <br> Voltage $10 \% \mathrm{~V}_{\mathrm{CC}}$ <br>  $5 \% \mathrm{~V}_{\mathrm{CC}}$ <br>  $5 \% \mathrm{~V}_{\mathrm{CC}}$ | $\begin{aligned} & \hline 2.5 \\ & 2.4 \\ & 2.7 \\ & 2.7 \end{aligned}$ |  |  | V | Min | $\begin{aligned} & \mathrm{l}_{\mathrm{OH}}=-1 \mathrm{~mA} \\ & \mathrm{l}_{\mathrm{OH}}=-3 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{OH}}=-1 \mathrm{~mA} \\ & \mathrm{l}_{\mathrm{OH}}=-3 \mathrm{~mA} \end{aligned}$ |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage $\quad 10 \% \mathrm{~V}_{\text {CC }}$ |  |  | 0.5 | V | Min | $\mathrm{l}_{\mathrm{OL}}=24 \mathrm{~mA}$ |
| $\mathrm{I}_{\mathrm{IH}}$ | Input HIGH Current |  |  | 5.0 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {IN }}=2.7 \mathrm{~V}$ |
| $\mathrm{I}_{\mathrm{BVI}}$ | Input HIGH Current <br> Breakdown Test |  |  | 7.0 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\mathrm{IN}}=7.0 \mathrm{~V}$ |
| $\overline{I_{\text {CEX }}}$ | Output HIGH <br> Leakage Current |  |  | 50 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\text {CC }}$ |
| $\mathrm{V}_{\text {ID }}$ | Input Leakage Test | 4.75 |  |  | V | 0.0 | $\mathrm{I}_{\mathrm{ID}}=1.9 \mu \mathrm{~A}$ <br> All Other Pins Grounded |
| $\overline{\mathrm{IOD}}$ | Output Leakage Circuit Current |  |  | 3.75 | $\mu \mathrm{A}$ | 0.0 | $\mathrm{V}_{\text {IOD }}=150 \mathrm{mV}$ <br> All Other Pins Grounded |
| IL | Input LOW Current |  |  | -0.6 | mA | Max | $\mathrm{V}_{\mathrm{IN}}=0.5 \mathrm{~V}$ |
| $\mathrm{I}_{\text {OzH }}$ | Output Leakage Current |  |  | 50 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {OUT }}=2.7 \mathrm{~V}$ |
| Iozl | Output Leakage Current |  |  | -50 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{\text {OUT }}=0.5 \mathrm{~V}$ |
| Ios | Output Short-Circuit Current | -60 |  | -150 | mA | Max | $\mathrm{V}_{\text {OUT }}=0 \mathrm{~V}$ |
| $\mathrm{l}_{\mathrm{zz}}$ | Bus Drainage Test |  |  | 500 | $\mu \mathrm{A}$ | 0.0V | $\mathrm{V}_{\text {OUT }}=5.25 \mathrm{~V}$ |
| ${ }^{\text {CCH }}$ | Power Supply Current |  |  | 56 | mA | Max | $\mathrm{V}_{\mathrm{O}}=\mathrm{HIGH}$ |
| $\mathrm{I}_{\text {CCz }}$ | Power Supply Current |  | 44 | 66 | mA | Max | $\mathrm{V}_{\mathrm{O}}=$ HIGH Z |

## AC Electrical Characteristics

| Symbol | Parameter | $\begin{gathered} \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} \end{gathered}$ |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{A}}=0^{\circ} \mathrm{C} \text { to }+70^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{CC}}=+5.0 \mathrm{~V} \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} \end{gathered}$ |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Max |  |
| $t_{\text {PLL }}$ | Propagation Delay | 6.0 | 11.0 | 16.0 | 6.0 | 17.0 | ns |
| $\mathrm{t}_{\text {PHL }}$ | $A_{n}$ to $\mathrm{O}_{\mathrm{n}}$ | 4.0 | 7.5 | 11.0 | 4.0 | 12.0 |  |
| $\mathrm{t}_{\text {PLL }}$ | Propagation Delay | 5.0 | 8.5 | 14.5 | 5.0 | 15.5 |  |
| $\mathrm{t}_{\text {PHL }}$ | $\bar{E}_{1}$ to $\mathrm{O}_{n}$ | 4.0 | 6.5 | 9.0 | 4.0 | 10.0 |  |
| tpli | Propagation Delay | 6.0 | 11.0 | 16.0 | 6.0 | 17.0 | ns |
| $\mathrm{t}_{\text {PHL }}$ | $\mathrm{E}_{2}$ to $\mathrm{O}_{\mathrm{n}}$ | 5.0 | 10.0 | 14.0 | 5.0 | 15.0 |  |
| $\mathrm{t}_{\text {PLH }}$ | Propagation Delay | 6.0 | 11.5 | 18.0 | 6.0 | 20.0 |  |
| $\mathrm{t}_{\text {PHL }}$ | P to $\mathrm{O}_{\mathrm{n}}$ | 6.0 | 11.0 | 16.0 | 6.0 | 17.0 |  |
| $\mathrm{t}_{\text {PZH }}$ | Output Enable Time | 3.0 | 5.5 | 10.5 | 3.0 | 11.5 | ns |
| $\mathrm{t}_{\text {PZL }}$ | $\overline{\mathrm{OE}}$ to $\mathrm{O}_{\mathrm{n}}$ | 5.0 | 9.0 | 13.0 | 5.0 | 14.0 |  |
| $t_{\text {PHZ }}$ | Output Disable Time | 2.0 | 4.0 | 6.0 | 2.0 | 7.0 |  |
| $t_{\text {tpL }}$ | $\overline{\mathrm{OE}}$ to $\mathrm{O}_{\mathrm{n}}$ | 3.0 | 5.0 | 7.0 | 3.0 | 8.0 |  |



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)


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